

Soft Magnetic Material Dynamic Hysteresisgraph System**Model MATS-2010M**

Automatic measurement on dynamic hysteresis loop of soft magnetic (silicon steel) material under 50Hz, 60Hz, 400Hz and 1kHz, accurate measurement on dynamic magnetic characteristic parameters such as amplitude permeability μ_a , loss angle δ , total losses P_s , remanence B_r and coercive force H_c .

Windows measurement software applied simply. The product conforms to China National Standards GB / T3655 - 92, GB / T13789 - 92 and international standard IEC60404 - 6.

Analog source (bridge), frequency meter, ammeter, voltmeter and wattmeter are replaced through computer control and A/D sampling, entire testing process automatically completed.

General Features**Software Features****Software Screen****Technical Data****Standard Package****System Specifications**

Under 50Hz frequency, use 25cm epstein frames to measure silicon steel sample, technical indices as follows:

Parameters measured	Bm (%)	Hm(%)	μ_a (%)	P_s (%)	δ (%)
Uncertainty ($k=2$)	1	1	2	1	2
Repeatability (constant temperature)	± 0.5	± 0.5	± 1	± 0.5	± 1

Instrument Specifications

MATS - 2010M Dynamic Hysteresisgraph	PC6111 A/D Card
Output Power: 500VA sine wave Frequency Range: 45Hz~ 1000Hz Frequency Fineness: 1Hz Frequency Error: < 0.05% Output Voltage: 0 ~ 10V ~ 50V ~ 150V ~ 300V, four automatic ranges Voltage Fineness: Program Control 1mV, panel < 0.1% * current range Voltage Distortion Factor: Superior to 0.5% Voltage Stability: Superior to 0.02% Sampling Current: 2mA, 5mA, 10mA, 20mA, 40mA, 80mA, 200mA, 400mA,	Conversion time: <= 2.5 μ s (every channel) Resolution and Linearity: 12 Bit $\pm 1/2$ LSB Voltage Range: ± 5 V ~ ± 10 V Sampling Clock: 5 μ s ~ 10ms Hardware Clock Internal Storage Capacity: 4k Byte Structure: PCI busbar

800mA, 1.6A, 4A, 8A (Peak Value)

Sample Voltage: 20mV, 40mV, 100mV, 200mV, 400mV, 800mV, 2V, 4V, 8V,

16V,

40V, 80V, 160V, 320V, 800V, 1600V (Peak Value)